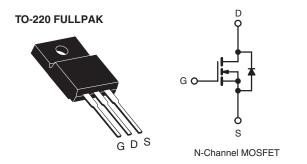


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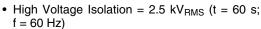
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	200			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 5.0 V	0.18		
Q _g (Max.) (nC)	66			
Q _{gs} (nC)	9.0			
Q _{gd} (nC)	38			
Configuration	Single			



FEATURES

· Isolated Package





- Sink to Lead Creepage Dist. 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4V and 5 V
- · Fast Switching
- · Ease of paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRLI640GPbF	
Lead (Fb)-liee	SiHLI640G-E3	
SnPb	IRLI640G	
SIFU	SiHLI640G	

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	200	V	
Gate-Source Voltage	V_{GS}	± 10			
Continuous Drain Current	V_{GS} at 5.0 V $T_{C} = 25 ^{\circ}\text{C}$	I-	9.9		
	V_{GS} at 5.0 $V_{C} = 100 ^{\circ}C$	I _D	6.3	Α	
Pulsed Drain Current ^a	I _{DM}	40	1		
Linear Derating Factor			0.32	W/°C	
Single Pulse Avalanche Energy ^b		E _{AS}	290	mJ	
Repetitive Avalanche Currenta	I _{AR}	9.9	Α		
Repetitive Avalanche Energy ^a	E _{AR}	4.0	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	40	W	
Peak Diode Recovery dV/dt ^c		dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s	•	300 ^d	7	
Manualina Tayana	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	6-32 OF IVIS SCIEW		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 4.4 \,\text{mH}$, $R_G = 25 \,\Omega$, $I_{AS} = 9.9 \,\text{A}$ (see fig. 12). c. $I_{SD} \le 17 \,\text{A}$, $\text{dI/dt} \le 150 \,\text{A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \,^{\circ}\text{C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLI640G, SiHLI640G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.27	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		1.0	-	2.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA	
Zana Oata Wallana Busin Oamani		V _{DS} =	V _{DS} = 200 V, V _{GS} = 0 V		-	25	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 V	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 160 °C		-	250		
5 . 6 . 6	_	V _{GS} = 5.0 V	I _D = 5.9 A ^b	-	-	0.18		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 5.0 A ^b	-	-	0.27	Ω	
Forward Transconductance	9 _{fs}	V _{DS} :	$V_{DS} = 50 \text{ V}, I_{D} = 10 \text{ A}^{b}$		-	-	S	
Dynamic		•						
Input Capacitance	C _{iss}		$V_{GS} = 0 \text{ V}, \\ V_{DS} = 25 \text{ V},$		1800	-		
Output Capacitance	C _{oss}	1			400	-	pF	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	120	-	1	
Total Gate Charge	Qg			-	-	66		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 17 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b	-	-	9.0	nC	
Gate-Drain Charge	Q _{gd}	1	see lig. 0 and 13		-	38	1	
Turn-On Delay Time	t _{d(on)}		1		8.0	-	ns	
Rise Time	t _r	$V_{DD} = 100 \text{ V, } I_{D} = 17 \text{ A,}$ $R_{G} = 4.6 \Omega, R_{D} = 5.7 \Omega,$ see fig. 10^{b}		-	83	-		
Turn-Off Delay Time	t _{d(off)}			-	44	-		
Fall Time	t _f			-	52	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	L _S			-	7.5	-	- nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol showing the		-	9.9	Α	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	40		
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 9.9 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.0	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 17 A, dl/dt = 100 A/μs ^b		-	310	470	ns	
Body Diode Reverse Recovery Charge	Q _{rr}				3.2	4.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

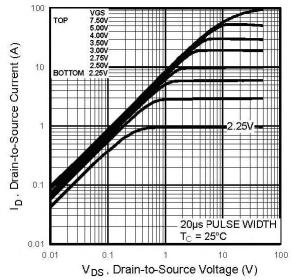


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

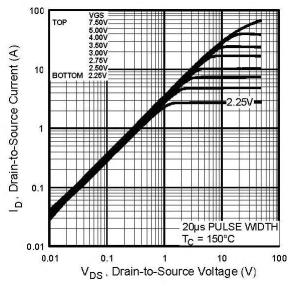


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

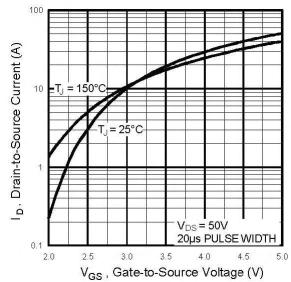


Fig. 3 - Typical Transfer Characteristics

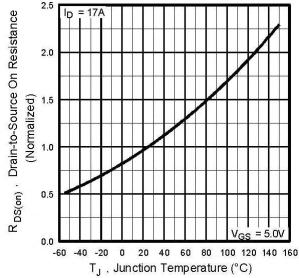


Fig. 4 - Normalized On-Resistance vs. Temperature

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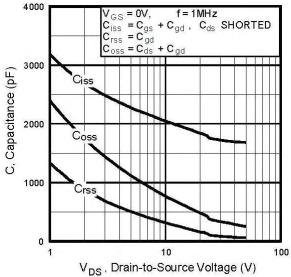
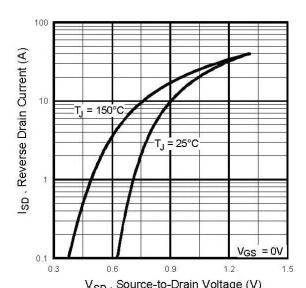


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



 $V_{SD}\,,\,Source\mbox{-to-Drain Voltage}\;(V)$ Fig. 7 - Typical Source-Drain Diode Forward Voltage

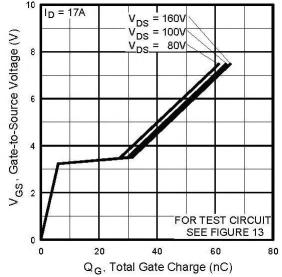


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

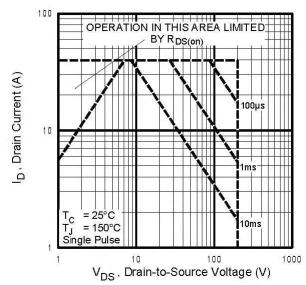


Fig. 8 - Maximum Safe Operating Area





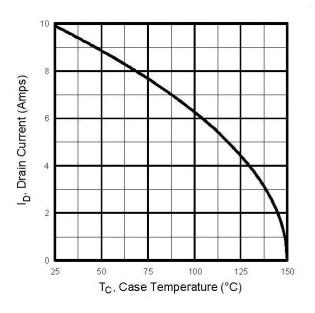


Fig. 9 - Maximum Drain Current vs. Case Temperature

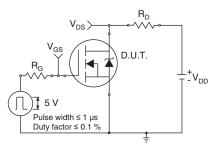


Fig. 10a - Switching Time Test Circuit

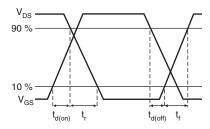


Fig. 10b - Switching Time Waveforms

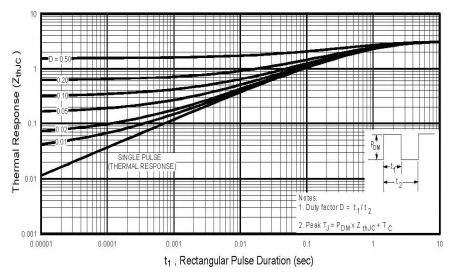


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

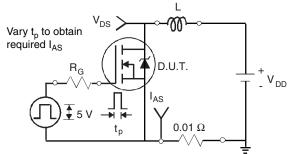


Fig. 12a - Unclamped Inductive Test Circuit

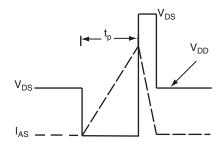


Fig. 12b - Unclamped Inductive Waveforms

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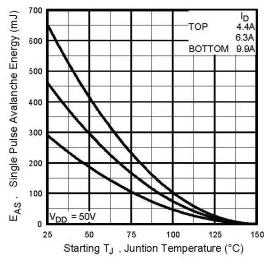


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

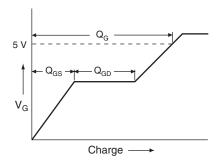


Fig. 13a - Basic Gate Charge Waveform

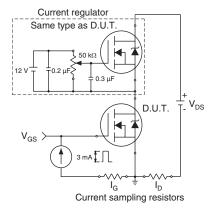
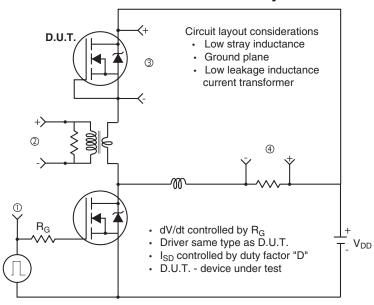
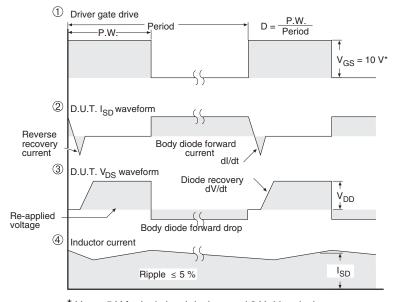


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





 * V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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